

<b>Notice of References Cited</b>	Application/Control No. 10/698,393		Applicant(s)/Patent Under Reexamination ODA ET AL.	
	Examiner Patrick J. Lee		Art Unit 2878	Page 1 of 1

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*	C	US-2004/0125226 A1	07-2004	Kubo, Naoki	348/340
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	M	US-			

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**NON-PATENT DOCUMENTS**

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